

High Power Rugged Type IGBT Module

Description

DAWIN's IGBT 6DM-2 Package devices are optimized to reduce losses and switching noise in high frequency power conditioning electrical systems. These IGBT modules are ideally suited for power inverters, motors drives and other applications where switching losses are significant portion of the total losses.

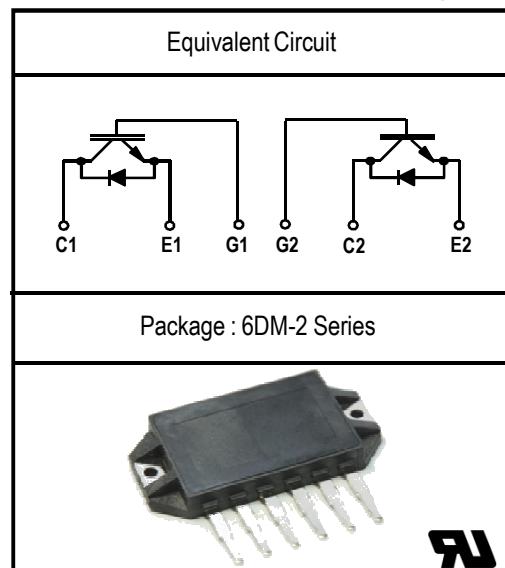
Features

- ☛ High Speed Switching
- ☛ $BV_{CES} = 600V$
- ☛ Low Conduction Loss : $V_{CE(sat)} = 2.1 V$ (typ.)
- ☛ Fast & Soft Anti-Parallel FWD
- ☛ Short circuit rated : Min. 10 μ s at $T_c=100^\circ C$
- ☛ Reduced EMI and RFI
- ☛ Isolation Type Package
- ☛ Built-in Dual Co-pack IGBT

Applications

Motor Drives, High Power Inverters, Welding Machine, Induction Heating, UPS, CVCF, Robotics, Servo Controls, High Speed SMPS

Equivalent Circuit and Package



Please see the package out line information



Absolute Maximum Ratings @ $T_j=25^\circ C$ (Per Leg)

Symbol	Parameter	Conditions	Ratings	Unit
V_{CES}	Collector-Emitter Voltage	-	600	V
V_{GES}	Gate-Emitter Voltage	-	± 20	V
I_C	Collector Current	$T_c = 25^\circ C$	125	A
		$T_c = 70^\circ C$	100	A
$I_{CM(1)}$	Pulsed Collector Current	-	200	A
I_F	Diode Continuous Forward Current	$T_c = 100^\circ C$	100	A
I_{FM}	Diode Maximum Forward Current	-	200	A
T_{SC}	Short Circuit Withstand Time	$T_c = 100^\circ C$	10	μ s
P_D	Maximum Power Dissipation	$T_c = 25^\circ C$	445	W
T_j	Operating Junction Temperature	-	-40 ~ 150	$^\circ C$
T_{stg}	Storage Temperature Range	-	-40 ~ 125	$^\circ C$
V_{iso}	Isolation Voltage	AC 1 minute	2500	V
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 9 seconds	-	260	$^\circ C$
	Mounting screw Torque :M3	-	4.0	N.m

Note : (1) Repetitive rating : Pulse width limited by max. junction temperature

Electrical Characteristics of IGBT @ $T_C=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Conditions	Values			Unit
			Min.	Typ.	Max.	
BV_{CES}	C - E Breakdown Voltage	$V_{\text{GE}} = 0\text{V}$, $I_{\text{C}} = 250\mu\text{A}$	600	-	-	V
$\Delta \text{BV}_{\text{CES}}$ /	Temperature Coeff. of	$V_{\text{GE}} = 0\text{V}$, $I_{\text{C}} = 1.0\text{mA}$	-	0.6	-	$\text{V}/^\circ\text{C}$
ΔT_J	Breakdown Voltage					
$V_{\text{GE}(\text{th})}$	G - E threshold voltage	$I_{\text{C}} = 500\mu\text{A}$, $V_{\text{CE}} = V_{\text{GE}}$	5	-	8.5	V
I_{CES}	Collector cutoff Current	$V_{\text{CE}} = 600\text{V}$, $V_{\text{GE}} = 0\text{V}$	-	-	250	μA
I_{GES}	G - E leakage Current	$V_{\text{GE}} = \pm 20\text{V}$	-	-	± 100	nA
$V_{\text{CE}(\text{sat})}$	Collector to Emitter	$I_{\text{C}} = 100\text{A}$, $V_{\text{GE}} = 15\text{V}$ @ $T_C = 25^\circ\text{C}$	-	2.1	2.8	V
	saturation voltage	$I_{\text{C}} = 100\text{A}$, $V_{\text{GE}} = 15\text{V}$ @ $T_C = 100^\circ\text{C}$	-	2.4	-	V
C_{ies}	Input capacitance	$V_{\text{GE}} = 0\text{V}$, $f = 1\text{MHz}$ $V_{\text{CE}} = 30\text{V}$	-	10000	-	pF
C_{oes}	Output capacitance		-	950	-	pF
C_{res}	Reverse transfer capacitance		-	230	-	pF
$t_{\text{d(on)}}$	Turn on delay time	$V_{\text{CC}} = 300\text{V}$, $I_{\text{C}} = 100\text{A}$ $V_{\text{GE}} = 15\text{V}$ $R_G = 6.8\Omega$ Inductive Load, @ $T_C = 25^\circ\text{C}$	-	25	-	nS
t_r	Turn on rise time		-	50	-	nS
$t_{\text{d(off)}}$	Turn off delay time		-	80	-	nS
t_f	Turn off fall time		-	110	200	nS
E_{on}	Turn on Switching Loss		-	4.8	-	mJ
E_{off}	Turn off Switching Loss		-	9.6	-	mJ
E_{ts}	Total Switching Loss		-	14.4	-	mJ
T_{sc}	Short Circuit Withstand Time	$V_{\text{CC}} = 300\text{V}$, $V_{\text{GE}} = 15\text{V}$ @ $T_C = 100^\circ\text{C}$	10	-	-	μs
Q_g	Total Gate Charge	$V_{\text{CC}} = 300\text{V}$ $V_{\text{GE}} = 15\text{V}$ $I_{\text{C}} = 100\text{A}$	-	400	510	nC
Q_{ge}	Gate-Emitter Charge		-	76	125	nC
Q_{gc}	Gate-Collector Charge		-	175	260	nC

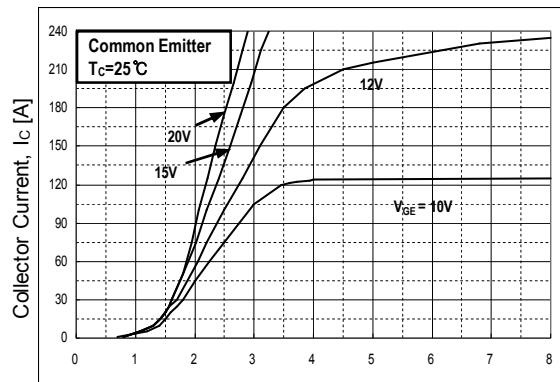
Electrical Characteristics of FRD @ $T_C=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Conditions	Values			Unit
			Min.	Typ.	Max.	
V_{FM}	Diode Forward Voltage	$I_F=100\text{A}$	$T_C=25^\circ\text{C}$	-	1.6	2.0
			$T_C=100^\circ\text{C}$	-	1.5	-
t_{rr}	Diode Reverse Recovery Time	$I_F=100\text{A}, V_R=300\text{V}$	$T_C=25^\circ\text{C}$	-	120	-
			$dI/dt = -200\text{A}/\mu\text{s}$	$T_C=100^\circ\text{C}$	-	130
I_{rr}	Diode Peak Reverse Recovery Current		$T_C=25^\circ\text{C}$	-	7.5	-
			$T_C=100^\circ\text{C}$	-	9	-
Q_{rr}	Diode Reverse Recovery Charge		$T_C=25^\circ\text{C}$	-	450	-
			$T_C=100^\circ\text{C}$	-	585	-

Thermal Characteristics and Weight

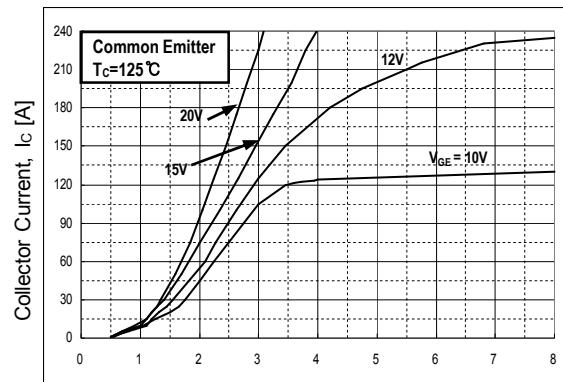
Symbol	Parameter	Conditions	Values			Unit
			Min.	Typ.	Max.	
$R_{\theta JC}$	Junction-to-Case(IGBT Part, Per 1/2 Module)		-	-	0.28	°C/W
$R_{\theta JC}$	Junction-to-Case(DIODE Part, Per 1/2 Module)		-	-	0.62	°C/W
$R_{\theta CS}$	Case-to-Sink (Conductive grease applied)		0.05	-	-	°C/W
Weight	Weight of Module		-	-	30	g

Performance Curves



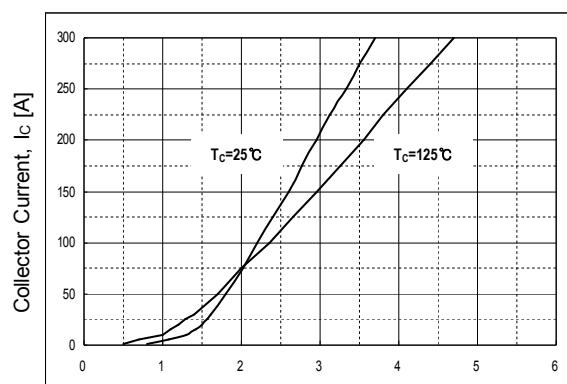
Collector – Emitter Voltage, $V_{CE(sat)}$ [V]

Fig 1. Typical Output characteristics



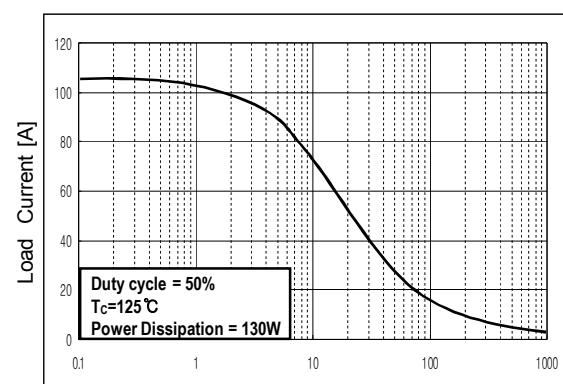
Collector – Emitter Voltage, $V_{CE(sat)}$ [V]

Fig 2. Typical Output characteristics



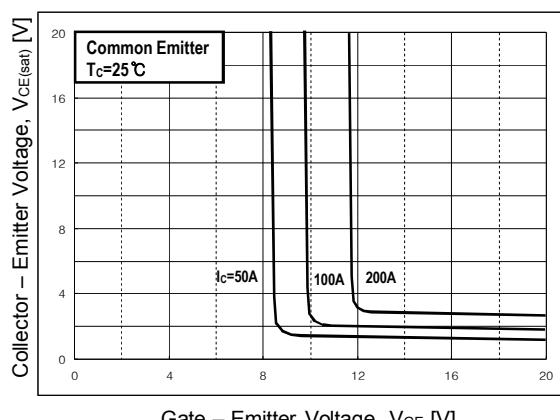
Collector – Emitter Voltage, $V_{CE(sat)}$ [V]

Fig 3. Typical Output characteristics



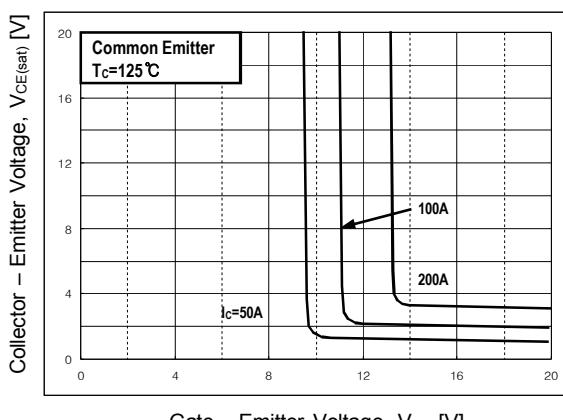
Frequency [KHz]

Fig 4. Load Current vs. Frequency



Gate – Emitter Voltage, V_{GE} [V]

Fig 5. Typical Saturation Voltage vs. V_{GE}



Gate – Emitter Voltage, V_{GE} [V]

Fig 6. Typical Saturation Voltage vs. V_{GE}

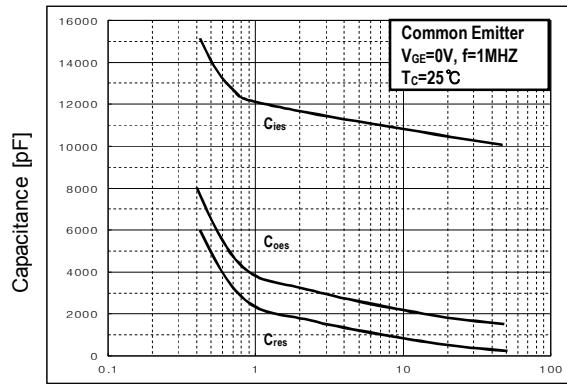


Fig 7. Capacitance characteristics

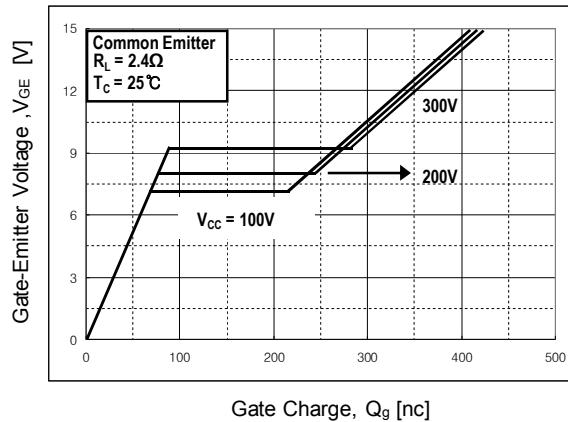


Fig 8. Gate Charge Characteristics

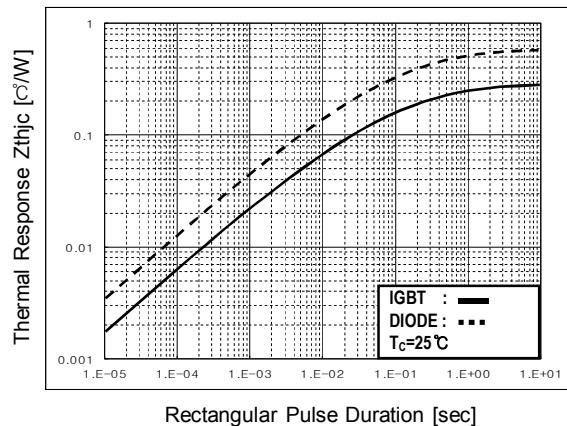


Fig 9. Transient Thermal Impedance

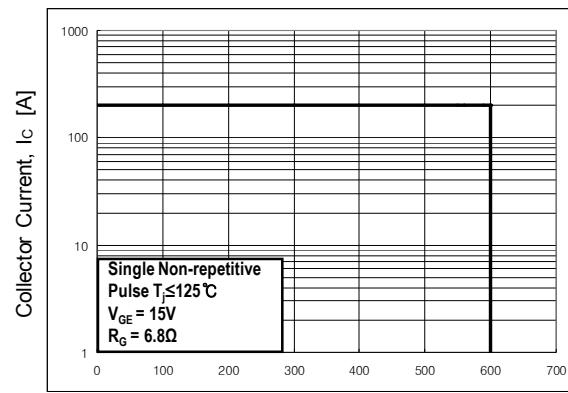


Fig 10. RBSOA Characteristic

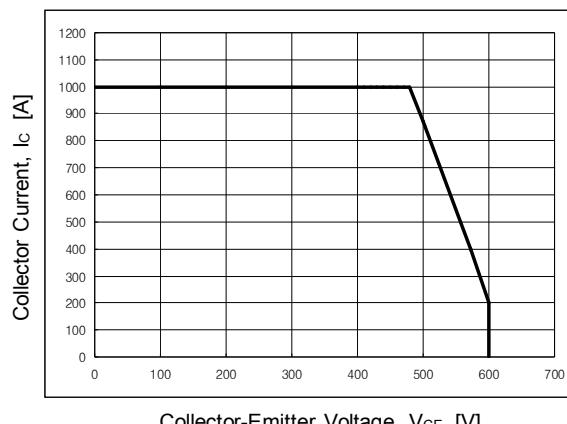


Fig 11. SC SOA Characteristic

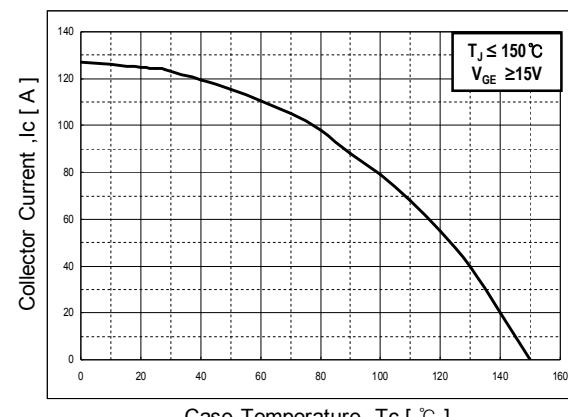


Fig 12. rated Current vs. Case Temperature

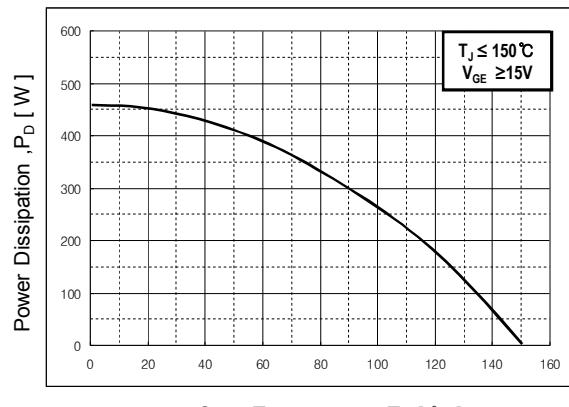


Fig 13. Power Dissipation vs. Case Temperature

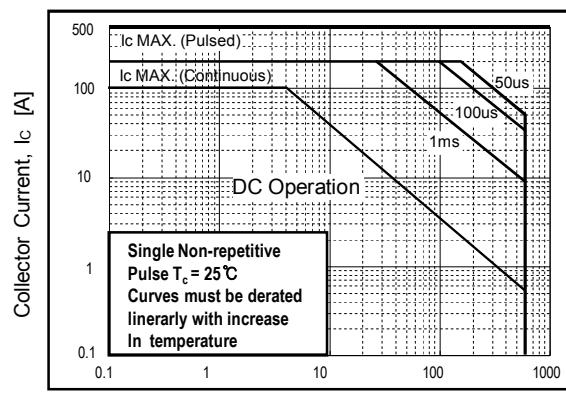


Fig 14. SOA characteristics

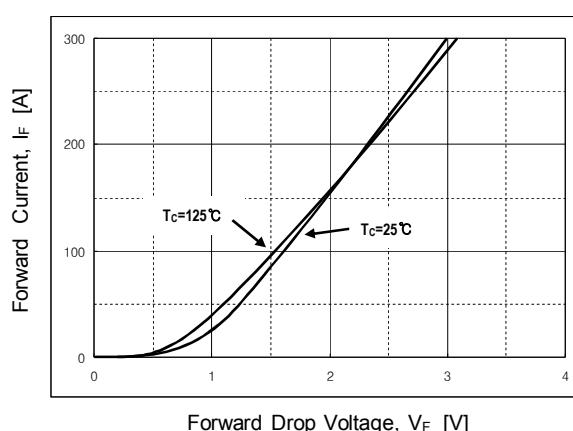
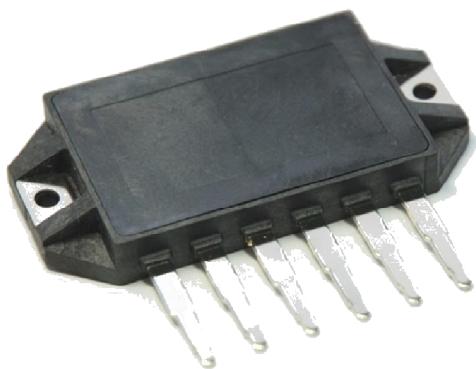


Fig 15. Forward characteristics

Package Out Line Information

6DM-2



UNIT : mm

